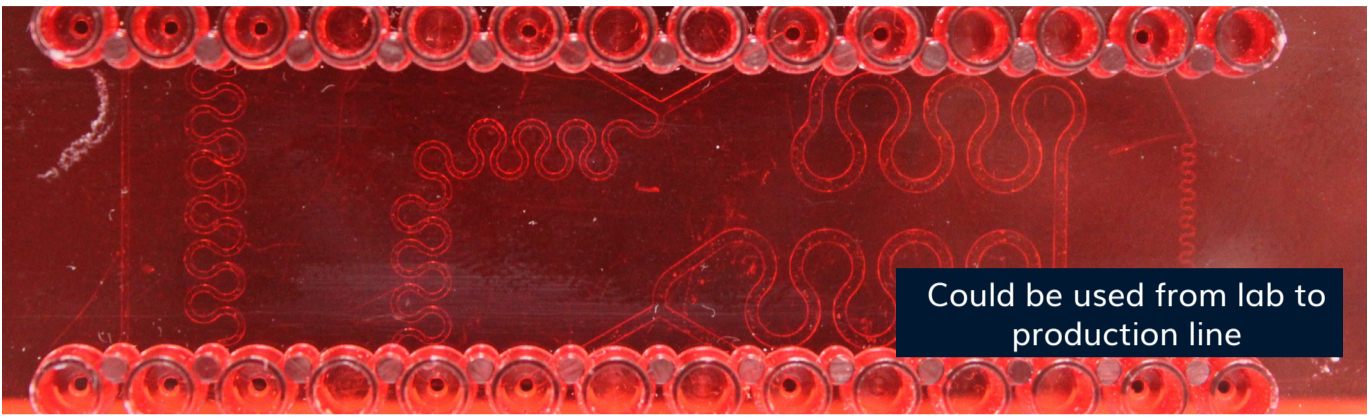


All-rounder for MST quality control

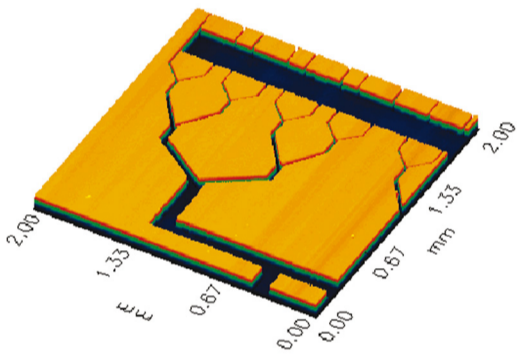


Could be used from lab to production line

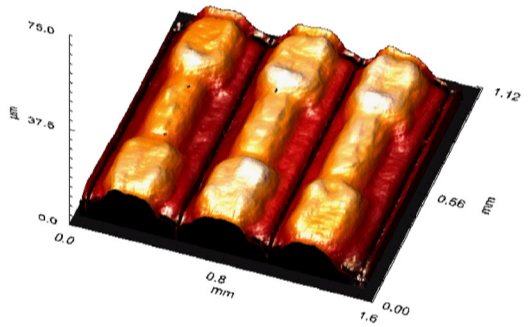
Ideally meet production needs in MST and microelectronics

- > every material – glasses, plastics, metals, semiconductors ...
- > measurements from nanometers to meters possible in one single instrument
- > roughness, waviness, shape, topography, film thickness, profile, geometry and much more
- > short measuring times, large measuring ranges and robust construction
- > for workers self testing or direct control of the manufacturing process
- > optical, non-contact and non-destructive

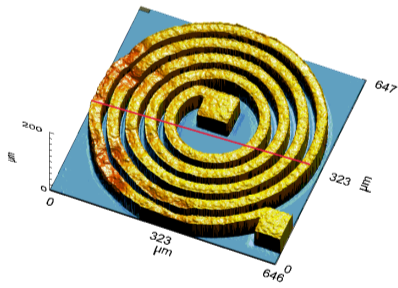
and much more...



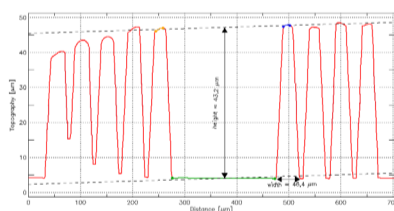
3D measurement of a micro fluidic structure



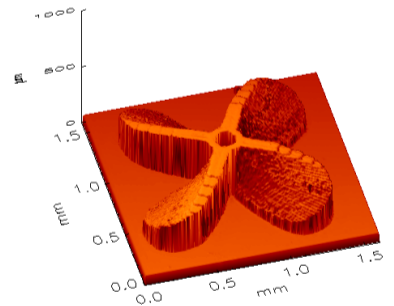
Topography measurement of conductor tracks



Step height and width of a quartz coil



Profile measurement along the red line, step height and width analysis



3D measurement of a plastic impeller

Example for technical solution



MicroProf® 200 - multi-sensor metrology tool